

Mathematical Modeling and Experimental Validation of Mixed Metal Oxide Thin Film Deposition by Spray Pyrolysis

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Abstract

The deposition of metal oxide films using Spray Pyrolysis Technique (SPT) is investigated through mathematical and physical modeling. A comprehensive model is developed in the processes including atomization, spray, evaporation, chemical reaction and deposition. The predicted results including particle size and film thickness are compared with the experimental data obtained in a complementary study. The predicted film thickness is in a good agreement with the measurements when the temperature is high enough for the chemical reaction to proceed. The model also adequately predicts the size distribution when the nanocrystals are well-structured at controlled temperature and concentration.

Keywords

ZnO Oxide Film, Mixed Metal Oxides, Film Growth, Modeling, Spray Pyrolysis

1. Introduction

Mixed metal oxide films are widely applied in solar cells, optoelectronics, gas sensors etc. [1] [2]. The synthesized film is typically composed of mixtures of electron donors (e.g. In_2O_3) and electron acceptors (e.g. ZnO , SnO_2). Several techniques have been used for synthesis of mixed metal oxide films such as Spray Pyrolysis Technique (SPT), Chemical Vapor Deposition (CVD), Sol-gel [3]. In order to synthesize the film with the desired properties, the morphology of the film must be controlled and largely predictable. The objective of this study is to develop a model for systematic investigation of the processes involved in mixed metal oxide deposi-

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tion by SPT in order to predict the film morphology.

SPT is a solution based method [4] utilizing thermal deposition of a metal precursor. It involves primarily five processes namely atomization, spray, evaporation, chemical reaction and film growth. Several approaches have been used to develop mathematical methods of the process. One approach involves descriptive models which mostly consider the physics of the process. Different spray methods and the deposition stages were studied by using this approach [5] and a conceptual model of the process was developed in previous study [6].

Evaporation and particle growth have been modeled using different approaches. The formation of solid particles in spray synthesis has been investigated [7] and a model was suggested for droplet evaporation and the transient droplet physical properties [8]. An evaporation model of droplets was developed to predict the size and composition of precipitates as the chemical reaction progressed [9]. The study demonstrated that increasing the temperature will increase the final particle size. Evaporation and drying for SPT was modeled and validated with the deposition of different materials [10].

Computational Fluid Dynamics (CFD) approach has been applied to study SPT deposition process. CFD was used to model spray droplets and the effect of heated environment on droplet characteristics [11]. A similar model was developed to investigate the evaporation phenomena in ethanol-NaCl-water droplet [12]. The atomization and evaporation of droplets were investigated, including the effect of swirl on the spraying of droplets onto a heated substrate in previous studies [13] [14].

Modeling the reaction and the film growth has been considered in some recent studies. These studies considered the variation of concentration within the droplets by defining the characteristic time constants. A comprehensive model which includes the evaporation and reaction stages was developed and validated for deposition of TiO₂ nano particles [15]. The atomization and decomposition processes were also considered. Droplet transport and interaction between droplets was assumed as Chemical Vapor Deposition phenomena [16]. The precursor was exposed to a heated substrate through inert gas and the film deposition was independent of direction, which facilitated model formulation. The model was validated by experimental results from deposition of tin chloride on silicon wafer substrate.

Considering that the flow rates of gas and precursor in both CVD and SPT methods can be controlled [17] for the same range of temperature [18], a novel approach is proposed in this paper to model the deposition of metal oxide thin films. Specifically, SPT and CVD can be assumed to be analogous when the solvent evaporates before the droplet hits the substrate, and subsequently reaches the surface in the vapor phase. The temperature of the substrate is considered at the range for which columnar film is expected to grow. This temperature permits the assumption that the residence and reaction times are on the same order.

2. Formulation

Figure 1 shows a schematic sketch of the spray pyrolysis experimental setup [19]. This process involves three major steps [19]: 1) Atomization of a precursor solution in the nozzle to tiny droplets; 2) Spraying of the droplets onto a preheated substrate; and 3) Synthesis and adherence of film to the substrate due to chemical reaction and thermal decomposition.

A comprehensive mathematical model of the SPT process can be considered in two broad categories. The first involves the atomization process and the second involves collectively the evaporation, chemical reaction and the film growth processes. The parameters associated with each process are listed in **Table 1**.

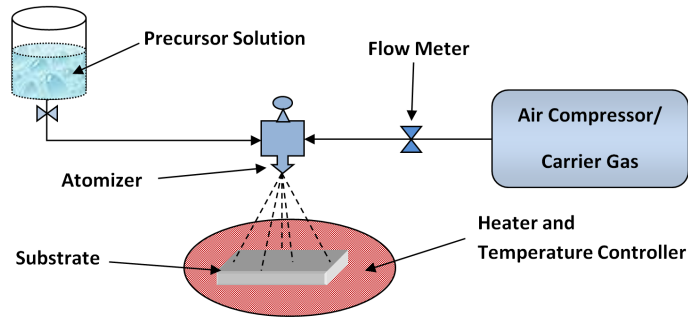
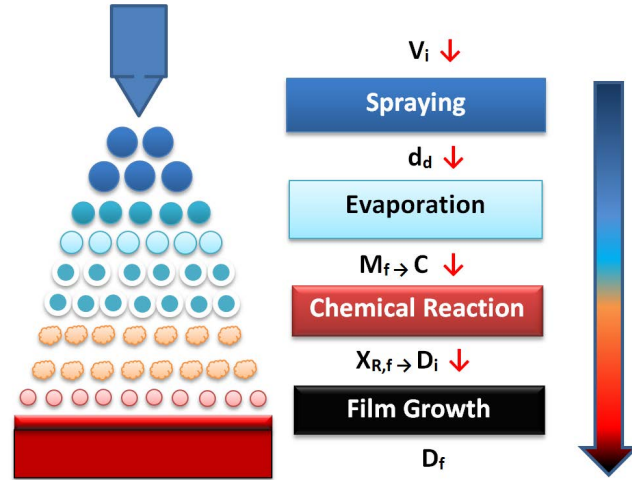
The major parameters associated with each process are shown in **Figure 2**. First, a spray model is developed to predict droplet diameter before reaching the substrate (d_d). The details of the spray model have been presented in previous papers [13] [20]. This CFD model also is used to determine the pressure and temperature distribution within the domain. The initial droplet mass (m_i) can be calculated from the droplet diameter and used in the subsequent evaporation model.

2.1. Evaporation

The evaporation rate of a single droplet is derived from mass conservation equation and simplified by assuming that the temperature inside the droplet reaches steady state condition. Therefore, a pseudo-steady state evaporation is proposed [15]. The solvent evaporation rate is determined by the decreasing droplet mass (m) and can be formulated as:

Table 1. Spray pyrolysis process models.

Model	Type	Input	Output
Spray	CFD model	T_s (Substrate temperature) V_i (Initial droplet velocity)	P (Pressure) T (Temperature) m_i (Initial droplet mass) d_d (Initial droplet diameter)
Evaporation	Math model	P (Pressure) T (Temperature) m_i (Initial droplet mass) d_d (Initial droplet diameter)	m_f (Final droplet mass)
Decomposition/ Reaction	Math model	T (Temperature) C (Initial concentration of precursor) derived from m_f	$x_{R,f}$ (Final fraction of precursor reacted) d_f (Final droplet diameter)
Deposition/ Growth	Math model	D_i (Initial film thickness) derived from d_f	D_f (Final film thickness)

**Figure 1.** Schematic sketch of chemical spray pyrolysis process.**Figure 2.** Schematic view of spray pyrolysis stages.

$$\frac{dm}{dt} = \frac{2\pi d_d D_v M}{N_A} (n_g - n_{sat}) \varphi \quad (1)$$

where D_v is the diffusion coefficient of solvent vapor in air, N_A is Avogadro's constant (6.0221413×10^{23} 1/mole), M is the molecular weight of water, and n_g and n_{sat} are the vapor concentrations at the droplet surface and in the surrounding air, respectively [15]. Initial mass (m_i) is determined from CFD modeling of

spray for a droplet at the substrate. This value considers the mass of water inside the droplet. In the specific experiment considered for validation, the precursor comprised 1% ZnCl_2 (for ZnO single oxide) and 5% ZnCl_2 + 95% $\text{In}(\text{NO}_3)_3$ (for ZnO + In_2O_3 mixed oxide) of the total mass of droplet. Therefore, the mass of precursor can be neglected in consideration of the total mass at this stage. The parameter φ in Equation (1) is the Knudsen correction which allows for the effect of transport when the size of droplet is on the order of the mean free path of molecules in air ($\lambda \sim 68$ nm):

$$\varphi = \frac{2\lambda + d_d}{d_d + 5.33 \left(\frac{\lambda^2}{d_d} \right) + 3.42\lambda} \quad (2)$$

where d_d is the droplet diameter.

The vapor concentration can be calculated as:

$$n_g = \frac{x_w P_g}{k_B T_{sat}} \quad (3)$$

$$n_{sat} = \frac{x_w P_{sat}}{k_B T_{sat}} \quad (4)$$

where P is the pressure and x_w is the mole fraction of solvent (water). The parameter D_v can be defined as [15]:

$$D_v = \frac{1.13 \times 10^{-5} \cdot T^{2.159}}{P} \quad (5)$$

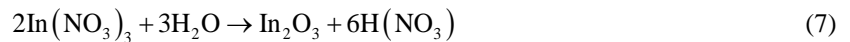
Since D_v , n_g and n_{sat} are dependent on surrounding air pressure (P) and temperature (T), the temperature and pressure are determined by CFD modeling of spray using the FLUENT software package which was developed in previous papers [13] [20]. The substrate temperature is fixed at 400°C as a reference.

By solving Equation (1) in MATLAB, the final mass (m_f) inside the droplet can be determined. This value can be used to calculate the initial droplet diameter (d_i) and the concentration of initial precursor (C) for the next stage.

2.2. Decomposition/Reaction

The pyrolysis of the precipitate starts before the precipitate reaches the substrate and nucleation and growth of thin films on the substrate occurs later. Subsequently, a continuous thin layer of metal oxide is synthesized by the growth of the nuclei. The desired condition is for the droplet to approach the substrate when the solvent has been largely removed [21].

A chemical reaction (thermal decomposition) occurs during spray pyrolysis in addition to the physical processes of evaporation and drying [15]. The chemical reaction for the system considered can be formulated as:



Since the decomposition rates of precursors are determined by the heating rate, a thermal analysis is performed at different heating rates to obtain the kinetic reaction equation as a function of activation energy [15]. Therefore, the general kinetic equation can be expressed as [15]:

$$\frac{d x_R}{dt} = A e^{(-E_a/RT)} f(x_R) \quad (8)$$

where $\frac{d x_R}{dt}$ is the reaction rate, R is gas constant (8.3144621 J/mol·K), x is the fraction of precursor reacted [ZnCl_2 and/or $\text{In}(\text{NO}_3)_3$], and $f(x_R)$ is the function of fraction reacted which depends on the mechanism of the decomposition reaction. This function represents the theoretical kinetic equation of the decomposition mechanism and it can be defined by normal grain growth model: $f(x_R) = (1 - x_R)^n$ where $n = 1.25$ is a

function of reaction order [15]. In Equation (8), A is the pre-exponential factor and E_a is the activation energy which can be determined from the Arrhenius kinetic reaction equation. By solving the differential Equation (8), the final x_R ($x_{R,f}$) can be found which is the fraction of the precursor reacted at the final stage.

The final diameter after chemical reaction is derived from the one-droplet to one-particle principle in spray pyrolysis [15] thus:

$$d_f = d_d \left(\frac{C \cdot M_p}{\rho_p} \right)^{1/3} \quad (9)$$

where d_f is the final particle diameter, d_d is initial droplet diameter, C is concentration of initial precursor, M_p is molecular weight of the generated particle, and ρ_p is the density of the generated particle (ZnO in single oxide and ZnO + In₂O₃ in mixed oxide). Since only a fraction of precursor is involved in the chemical reaction at this stage, the final droplet diameter needs to be modified accordingly. Therefore, the final droplet size is corrected using the $x_{R,f}$ factor. In effect, when $x_{R,f} = 1$, the final d_f is equal to the calculated diameter, and when $x_{R,f} = 0$, there is no particle created and $d_f = 0$.

2.3. Deposition/Growth

The growth rate in a spray deposition process is linearly dependent on spray time and logarithmically dependent on the substrate temperature [16]. The experimental results of the study are in good agreement with the Arrhenius expression. Therefore the rate can be represented by:

$$\frac{dD}{dt} = A_1 e^{(-E/k_B T)} \quad (10)$$

where D is the film thickness, A_1 is the growth rate coefficient, T is temperature, t is time and k_B is the Boltzmann constant ($=1.3806488 \times 10^{-23} \text{ m}^2 \cdot \text{kg/s}^2 \cdot \text{K}$). Based on the experimental results, the following parameters were used to solve Equation (10): $A_1 = 3.1 \mu\text{m}$, $t = 30 \text{ s}$, $T = 400^\circ\text{C}$, $E = 0.427 \text{ eV}$. Since the amount of indium nitrate in the mixture is less than 20%, the same growth rate coefficient can be used for the mixed oxide cases.

The initial film thickness (D_i) is derived from the reaction stage. Specifically, the final droplet diameter (d_f) at that stage is assumed to be the same as the initial film thickness, assuming a spherical particle shape. The final film thickness (D_f) is predicted subsequently by solving Equation (10). It should be remarked that since the precursor solution used for the spray is typically dilute, the above model is expected to be valid for both single and mixed oxides.

An experimental study was conducted to validate the modeling results. In the experiment, the precursor solution is sprayed onto a heated alumina substrate using spray pyrolysis. The precursor solution consists of a mixture of ZnCl₂ and In(NO₃)₃ dissolved in water for synthesis of ZnO + In₂O₃ and only ZnCl₂ for ZnO single oxide. The optimum processing conditions are strongly dependent on the composition of the precursor solution.

The deposited single and mixed oxide thin films are subsequently characterized by Scanning Electron Microscopy (SEM) for the particle size and film thickness. SEM combines high spatial resolution with a wide field of view to improve accuracy [22]. Image processing techniques are applied on the SEM micrographs to determine particle size distribution. Specifically, the mean diameter of each particle is obtained from which the average particle size is determined for all particle dimensions. The mean area of particles (\bar{A}) is calculated by considering the total number of particles and the space intervals, thus [23]:

$$\bar{A} = A + \left(\sum f d / N \right) i \quad (11)$$

where \bar{A} is the actual mean area, A is the assumed mean area, i is the class interval between particles, d is deviation of midpoint from assumed mean, and N is total number of particles considered. Table 2 summarizes the input data used for the experiments.

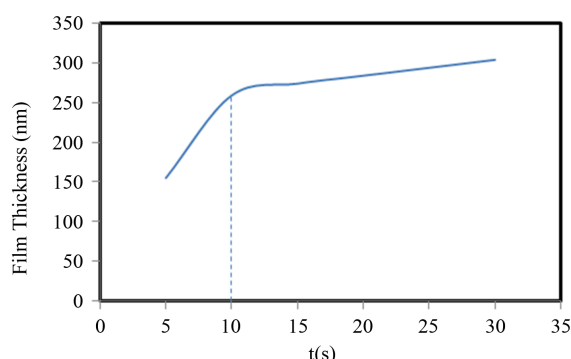
3. Results

3.1. Film Thickness

Figure 3 shows the predicted variation of ZnO film thickness with deposition duration. The film initially grows

Table 2. Experimental parameters used for deposition of ZnO and ZnO + In₂O₃ films.

Deposited metal oxide	Concentration (mol/lit)	Temperature (°C)
ZnO	0.1	350
ZnO	0.1	400
ZnO	0.2	400
ZnO	0.3	400
25 wt% ZnO + 75 wt% In ₂ O ₃	0.1	400
80 wt% ZnO + 20 wt% In ₂ O ₃	0.1	400

**Figure 3.** Predicted variation of ZnO film thickness with deposition time ($T = 400^{\circ}\text{C}$, $C = 0.2$ mol/lit).

rapidly and after a certain duration (~ 10 s), becomes gradual. The result illustrates the role of mass diffusion in the growth of crystalline structures. This observed trend may be attributed to space limitation on the substrate surface and pressure from adjacent growing particles which subsequently limit the growth rate. At long time duration, the growth rate is limited by diffusion at a constant level in the consensus of previous studies [24].

Figure 4 shows the predicted variation of ZnO film thickness with substrate temperature. Increasing the substrate temperature enhances the growth of particles on the surface. This trend is consistent with the direct influence of temperature on both diffusion and chemical reaction. It should be noted that the threshold deposition time of 10 s of previous **Figure 3** which produced a film thickness of 272 nm corresponds to a temperature of 400°C in **Figure 4**.

Table 3 compares the film thickness of ZnO films obtained from modeling and experiments at two substrate temperatures. The experiment was performed with deposition duration of 10 s which is the threshold deposition time obtained from the model (**Figure 3**). The model predicts the film thickness on the same order as the experiment and the accuracy is quite good ($<3\%$ error) at the higher temperature of 400°C . The improved model accuracy at higher temperature is attributed to the heat loss in the experiment which impedes film growth. Some of the heat loss is compensated at the higher temperatures. These results are also consistent with **Figure 3** and **Figure 4**. Thus the proposed model has the potential to successfully predict the optimum processing parameters for the film synthesis.

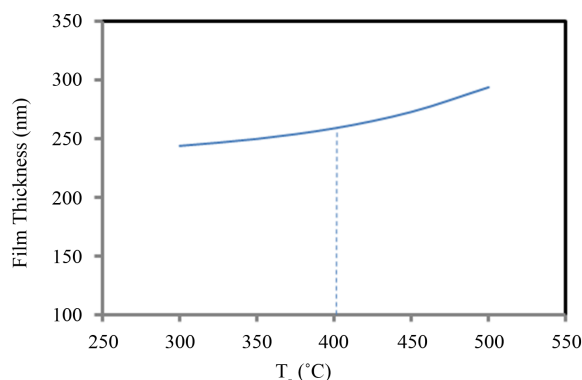
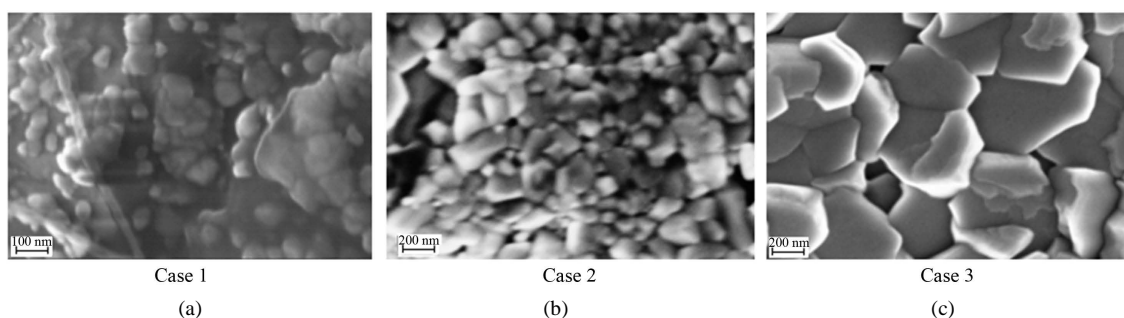
3.2. Particle Size

Figures 5(a)–(c) show the SEM micrographs of single ZnO oxides processed at defined temperature and different concentrations. At low concentration ($C = 0.1$ mol/lit) (**Figure 5(a)**), small spherical crystallites are formed that agglomerate at the surface in the shape of powder. The average particle size is 112 nm which is in the consensus of previous studies [25]–[27].

The properties of particles change by increasing the concentration. The grain size increases with increase in the amount of precursor dissolved in solution in **Figure 5(b)** as was also observed in previous studies [28] [29]. The film is mostly homogenous with average nanoparticle size of about 119 nm. The particles exhibit the

Table 3. Predicted and measured thickness of ZnO films.

Temperature (°C)	Concentration (mol/lit)	Time (s)	Measured film thickness (nm)	Predicted film thickness (nm)
350	0.1	10	112	169
400	0.2	10	233	214

**Figure 4.** Predicted variation of ZnO film thickness with substrate temperature ($T = 400^{\circ}\text{C}$, $C = 0.2$ mol/lit).**Figure 5.** SEM micrographs of spray pyrolysis deposition of ZnO thin films on Al_2O_3 substrate: (a) $T = 400^{\circ}\text{C}$ and $C = 0.1$ mol/lit; (b) ZnO at $T = 400^{\circ}\text{C}$ and $C = 0.2$ mol/lit; and (c) ZnO at $T = 400^{\circ}\text{C}$ and $C = 0.3$ mol/lit.

xagonal flake morphology similar to a previous study [30]. Upon further increase in concentration ($C = 0.3$ mol/lit), the density and size of particles are increased to an average size of 233 nm. In this case, the crystals are plate-like and the sides of the walls are grown packed together (Figure 5(c)). A similar hexagonal wurtzite structure has also been observed at high concentration [1].

Figure 6(a) and Figure 6(b) show the SEM micrographs of ZnO + In_2O_3 mixed oxide thin films on Al_2O_3 substrate at $T = 400^{\circ}\text{C}$ composed of 25% of ZnO mixed with 75% of In_2O_3 (Figure 6(a)), and 80% of ZnO mixed with 20% of In_2O_3 (Figure 6(b)). At lower composition ratio of ZnO (Figure 6(a)), the growth of particle side walls results in the formation of nano tubes [28] [31]. By increasing the amount of zinc (Figure 6(b)), crystallization is enhanced and a well-structured thin film is synthesized. In this case, there is a better chance to produce ZnO crystals or rods [28]. This result confirms that the overall particle size is increased when the concentration of In_2O_3 is decreased. The observed trend may be attributed to the fact that indium ions limit the growth of ZnO particles on the surface. The grain size has been observed to decrease by increasing the indium doping [32]. This is attributed to the stresses applied by the mixture which limits the growth of grain size.

The results show that addition of In_2O_3 component to ZnO results in the growth of particles over a wider size range as was also observed in a previous study [33]. Thus the particles are deposited with less homogeneity compared to the single oxide ZnO. A comparison of Figure 6(a) and Figure 6(b) also shows that the film is more homogenous when ZnO is the dominant precursor. At low concentration of ZnO, the structure of the mixed oxide is similar to that obtained for single oxide ZnO in Figure 5(c). However the average particle size obtained (~136 nm) is less than the single oxide. The value predicted from the mathematical model for the mixed oxide of

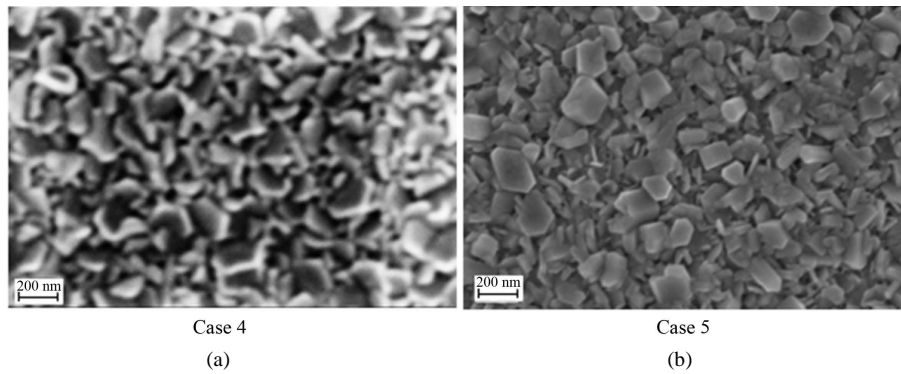


Figure 6. SEM micrographs of spray pyrolysis deposition of ZnO + In₂O₃ thin films on Al₂O₃ substrate: (a) 0.25ZnO + 0.75In₂O₃ at $T = 400^{\circ}\text{C}$ and $C = 0.1$ mol/lit; and (b) 0.8ZnO + 0.2In₂O₃ at $T = 400^{\circ}\text{C}$ and $C = 0.1$ mol/lit.

Table 4. Predicted and measured particle size for single and mixed oxides.

Case	Deposited oxide	Temperature ($^{\circ}\text{C}$)	Concentration (mol/lit)	Measured particle size (nm)	Predicted particle size (nm)
1	ZnO	400	0.1	112	189
2	ZnO	400	0.2	119	234
3	ZnO	400	0.3	233	265
4	25 wt% ZnO + 75 wt% In ₂ O ₃	400	0.1	136	209
5	80 wt% ZnO+20 wt% In ₂ O ₃	400	0.1	201	244

Figure 6(a) is 209 nm which is lower than the corresponding value for ZnO deposition. This value is however still in the range of the measured particle size. The predicted particle size is 244 nm at the higher concentration of ZnO (**Figure 6(b)**). **Table 4** summarizes the values of the average particle sizes obtained from modeling and experiments.

The agreement between the experimental measurements and modeling is generally acceptable and the results are on the same order of magnitude. The agreement is particularly good when the deposited film is completely well-structured and the crystal shapes are fully formed as in cases 3 and 5 for which the maximum error is less than 14% in case 3.

4. Discussion

A comprehensive mathematical model has been developed to simulate film deposition by Spray Pyrolysis Technique (SPT). The mechanism underlying film growth by SPT was systematically investigated, enabling identification of the essential processes necessary for the development of a comprehensive model. Thus, the model was divided into four sub-models: Atomization, Evaporation, Decomposition and Growth based on the underlying physical and chemical mechanisms. The model developed is applicable to the growth of both single oxide (ZnO) and mixed oxide (ZnO + In₂O₃). The predicted results (particle size and film thickness) were validated by comparison with the experimental data obtained in a complementary processing study.

The predicted results demonstrate the important roles that temperature, concentration and deposition duration play on film growth. This finding is in agreement with previous studies. The model however extends beyond the experiment by indicating the threshold deposition duration at which the initial rapid film growth ceases and the film thickness stabilizes by diffusion.

The model has been corroborated by the experimental data for both single oxide (ZnO) and mixed oxide (ZnO + In₂O₃) film growth. Both sets of results indicate that by increasing the concentration of precursors, particles grow faster and develop into large-sized crystals. At low concentration, the particles are smaller and the size distribution is less homogeneous. The results also indicate random orientation of crystallites and smaller particle

sizes at low temperature.

SEM micrographs of synthesized films were used to measure particle size distribution on film surface. The predicted and measured particle size and film thickness are on the same order of magnitude. The accuracy of the model significantly improves at high substrate temperatures for which the reaction rate is close to the stoichiometric condition.

The mathematical model developed could potentially be applied in a variety of situations. For example, the results from the decomposition model can be used to determine the optimum condition to synthesize thin films with homogeneous particle size distribution.

Acknowledgements

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